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Substitute	for form 1449/PTC	,		Application Number	10/635862	
	RMATION D			Filing Date	2003-08-05	
STATI	EMENT BY	APPLIC	ANT	First Named Inventor DELUCA, Michael J. et al.		
/Use as	many sheets as ne	cessary)		Art Unit	2622	
	,			Examiner Name	Nicholas G. Giles	
Sheet	1	of	11	Attorney Docket No: FN-10	11-CIP-US	

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	Pages, Columns,				
Examiner Initials*	Cite No. ¹	Number-Kind Code ^{2(if known)}	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Lines, Where Relevant Passages or Relevant Figures Appear
	001	US-4577219	03-18-1986	KLIE; Jurgen et al.	
	002	US-4646134	02-24-1987	KOMATSU; Kousuke et al.	
	003	US-4777620	10-11-1988	SHIMONI; Yair et al.	
	004	US-4881067	11-14-1989	WATANABE; Osamu et al.	
	005	US-4978989	12-18-1990	NAKANO; Toshifumi et al.	
	006	US-5164831	11-17-1992	KUCHTA; Daniel W. et al.	
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	008	US-5249053	09-28-1993	JAIN; Jaswant R.	
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	010	US-5301026	04-05-1994	LEE; Young-man	
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Examiner Initials*	Cite No. ¹	Number-Kind Code ^{2(if known)}	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Lines, Where Relevant Passages or Relevant Figures Appear
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	023	US-5734425	03-31-1998	TAKIZAWA; Yoshinori et al.	
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	026	US-5805727	09-08-1998	NAKANO; Hiroki	
	027	US-5815749	09-29-1998	TSUKAHARA; Daiki et al.	
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	RMATION D			Filing Date	2003-08-05
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	051	US-6381345	04-30-2002	SWAIN; Cassandra Turner	
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	058	US-6614471	09-02-2003	OTT; Cynthia D.	
	059	US-6621867	09-16-2003	SAZZAD; Sharif et al.	
	060	US-6628833	09-30-2003	HORIE; Daisaku	
	061	US-6714665	03-30-2004	HANNA; Keith James et al.	
	062	US-6786655	09-07-2004	COOK; Stacy S. et al.	
	063	US-6798913	09-28-2004	TORIYAMA; Hideyuki	

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Examiner Initials*	Cite No.1	Number-Kind Code ^{2(if known)}	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Lines, Where Relevant Passages or Relevant Figures Appear
	064	US-6859565	02-22-2005	BARON; John M.	
	065	US-7024051	04-04-2006	MILLER; Michael E. et al.	
	066	US-7027662	04-11-2006	BARON; John M.	
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	068	US-7133070	11-07-2006	WHEELER; Richard B. et al.	
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	070	US-7224850	05-29-2007	ZHANG; Lei et al.	
	071	US-7269292	09-11-2007	STEINBERG; Eran	
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	080	US-7454040	11-18-2008	LUO; Huitao et al.	
	081	US-7515740	04-07-2009	CORCORAN; Peter et al.	
	082	US-2001031142A1	10-18-2001	WHITESIDE, George D.	
	083	US-2001052937A1	12-20-2001	SUZUKI, Toshihiko	
	084	US-2002019859A1	02-14-2002	WATANABE, Kouji	

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	085	US-2002051571A1	05-02-2002	JACKWAY, Paul et al.	
	086	US-2002090133A1	07-11-2002	KIM, Sang-kyun et al.	
	087	US-2002105662A1	08-08-2002	PATTON, David L. et al.	
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	089	US-2002126893A1	09-12-2002	HELD, Andreas et al.	
	090	US-2003025808A1	02-06-2003	PARULSKI, Kenneth A. et al.	
	091	US-2003044176A1	03-06-2003	SAITOH, Noboru	
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	093	US-2003058343A1	03-27-2003	KATAYAMA, Takeshi	
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	096	US-2004047491A1	03-11-2004	RYDBECK, Bo	
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	099	US-2004239779A1	12-02-2004	WASHISU, Koichi	
	100	US-2005068452A1	03-31-2005	STEINBERG; Eran et al.	
	101	US-2005074179A1	04-07-2005	WILENSKY; Gregg D.	
	102	US-2005147278A1	07-07-2005	RUI; Yong et al.	
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ľ	Sheet	6	of	11	Attorney Docket No: FN-10	1-CIP-US	_

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Examiner Initials*	Cite No.1	Document Number Number-Kind Code ^{2(if known)}	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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	107	US-2006038916A1	02-23-2006	KNOEDGEN; Horst et al.	
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Substitute	for form 1445/PTC	,		Application Number	10/635862	
	MATION D			Filing Date	2003-08-05	
STATE	MENT BY	APPLIC	ANT	First Named Inventor	DELUCA, Michael J. et al.	
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 /Andrew V. Smith/
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